

## CLAIMS

What is claimed is:

1 1. A microelectromechanical device, comprising  
2 a) a rotating element including a first electrode;  
3 b) a second electrode;  
4 *Sub H* c) means, coupled to the first and second electrodes  
5 for measuring a capacitance between them; and  
6 d) means coupled to the capacitance sensing means for  
7 determining from the capacitance a digital control  
8 state of the device.

1 2. The device of claim 1 further comprising means for  
2 determining a deviation from a desired control state.

1 3. The device of claim 1 wherein the element has two  
2 control states.

1 4. The device of claim 1, further comprising means for  
2 rotating the rotatable element.

1 5. The device of claim 1 wherein the element is a MEMS  
2 mirror.

1 6. A microelectromechanical system (MEMS) apparatus,  
2 comprising  
3 a) an element configured to rotate between a first  
4 angular position and a second angular position;  
5 *Sub H2* b) one or more electrodes disposed proximate the element,  
6 wherein a capacitance between the element and the  
7 electrode has a first value when the element is in a  
8 first control state and the capacitance has a second  
9 value when the element is in a second control state;

- 10 c) means, for measuring a value the capacitance between  
 11 the element and the at least one of the one or more  
 12 electrodes; and  
 13 d) means coupled to the capacitance sensing means for  
 14 determining a control state of the element from the  
 15 value of the capacitance.

1 7. The device of claim 6 wherein the first and second  
 2 angular positions are substantially 90° apart.

1 8. The device of claim 6 further comprising means for  
 2 actuating the element.

1 9. The device of claim 6 further comprising means for  
 2 electrostatically clamping the element in at least one of  
 3 the first and second positions.

1 10. The device of claim 9, wherein the clamping means  
 2 comprises a clamping voltage source electrically  
 3 coupled to one or more of the one or more  
 4 electrodes.

1 11. The device of claim 6, further comprising a substrate,  
 2 wherein the element connected to the substrate by a  
 3 hinge.

1 12. The device of claim 11, wherein the one or more  
 2 electrodes includes an electrode disposed on the  
 3 substrate proximate the element.

1 13. The device of claim 11, wherein the substrate  
 2 includes a vertical stop disposed proximate the  
 3 element.

1 14. The device of claim 13, wherein the one or more  
 2 electrodes includes an electrode attached to the  
 3 vertical stop.

1 15. The device of claim 6, wherein the element is a MEMS  
2 mirror.

1 16. A method for sensing the control state of a  
2 microelectromechanical device, comprising:

3 a) providing an element that is rotatable relative to a  
4 static part between a first control state and a second  
5 control state;

6 b) disposing a first electrode and a second electrode  
7 proximate element; and

8 c) measuring a value of a capacitance between the element  
9 and one or more of the first and second electrodes to  
10 determine whether the element is in the first control  
11 state, the second control state, or neither the first nor  
12 second control state.

1 17. The method of claim 16, further comprising applying an  
2 electrostatic clamping voltage to one or more of the  
3 first and second electrodes.

1 18. The method of claim 17, wherein the clamping  
2 voltage is a DC voltage and c) includes  
3 superimposing an AC signal on the clamping  
4 voltage.

1 19. The method of claim 17, wherein the clamping  
2 voltage and a sensing signal are alternately  
3 applied in time.

1 20. The method of claim 16 further comprising determining  
2 the presence of a fault in the microelectromechanical  
3 device from the value of the capacitance.

1 21. The method of claim 16 further comprising using the  
2 value of the capacitance to time the actuation of the  
3 element.

22. An optical communications system, comprising:

- a) one or more input optical fibers;
- b) one or more output optical fibers;
- c) a microelectromechanical system (MEMS) optical switch including:
  - i) one or more MEMS mirrors configured to rotate between a first angular position and a second angular position;
  - ii) one or more electrodes disposed proximate each of the one or more mirrors, wherein a capacitance between the mirrors and the electrodes has a first value when the mirrors are in a first control state and the capacitance has a second value when the element is in a second control state;
  - iii) means, for measuring a value the capacitance between at least one of the one or more mirrors and the at least one of the one or more electrodes; and
  - iv) means coupled to the capacitance sensing means for determining a control state of the element from the value of the capacitance.